



US00D373315S

United States Patent [19]

Ninomiya et al.

[11] Patent Number: **Des. 373,315**

[45] Date of Patent: ****Sep. 3, 1996**

[54] SPECTRO PHOTOMETER

[75] Inventors: **Atsushi Ninomiya; Isamu Takekoshi**, both of Tokyo; **Masaya Kojima**, Mito, all of Japan

[73] Assignee: **Hitachi, Ltd.**, Tokyo, Japan

[**] Term: **14 Years**

[21] Appl. No.: **41,934**

[22] Filed: **Jul. 27, 1995**

[52] U.S. Cl. **D10/75; D10/81; D14/100**

[58] Field of Search **D10/75, 81; D14/100, D14/106; D24/165; 356/326, 328, 406, 407, 426, 428**

[56] References Cited

U.S. PATENT DOCUMENTS

D. 329,614 9/1992 Ando et al. D10/75 X

OTHER PUBLICATIONS

Cole-Palmer, Spectrophotometers; ©1995; p. 1263.

Primary Examiner—Antoine Duval Davis

Attorney, Agent, or Firm—Antonelli, Terry, Stout & Kraus

[57] CLAIM

The ornamental design for a spectro photometer, as shown and described.

DESCRIPTION

FIG. 1 is a front, top and right side perspective view of a spectro photometer showing our new design;

FIG. 2 is a front elevational view thereof;

FIG. 3 is a top plan view thereof;

FIG. 4 is a right side view thereof;

FIG. 5 is a left side view thereof;

FIG. 6 is a rear elevational view thereof;

FIG. 7 is a bottom plan view thereof;

FIG. 8 is a front, top and right side perspective view in condition that the cover of display is rotated; and,

FIG. 9 is a front, top and right side perspective view in condition that the cover of display is closed.

1 Claim, 6 Drawing Sheets

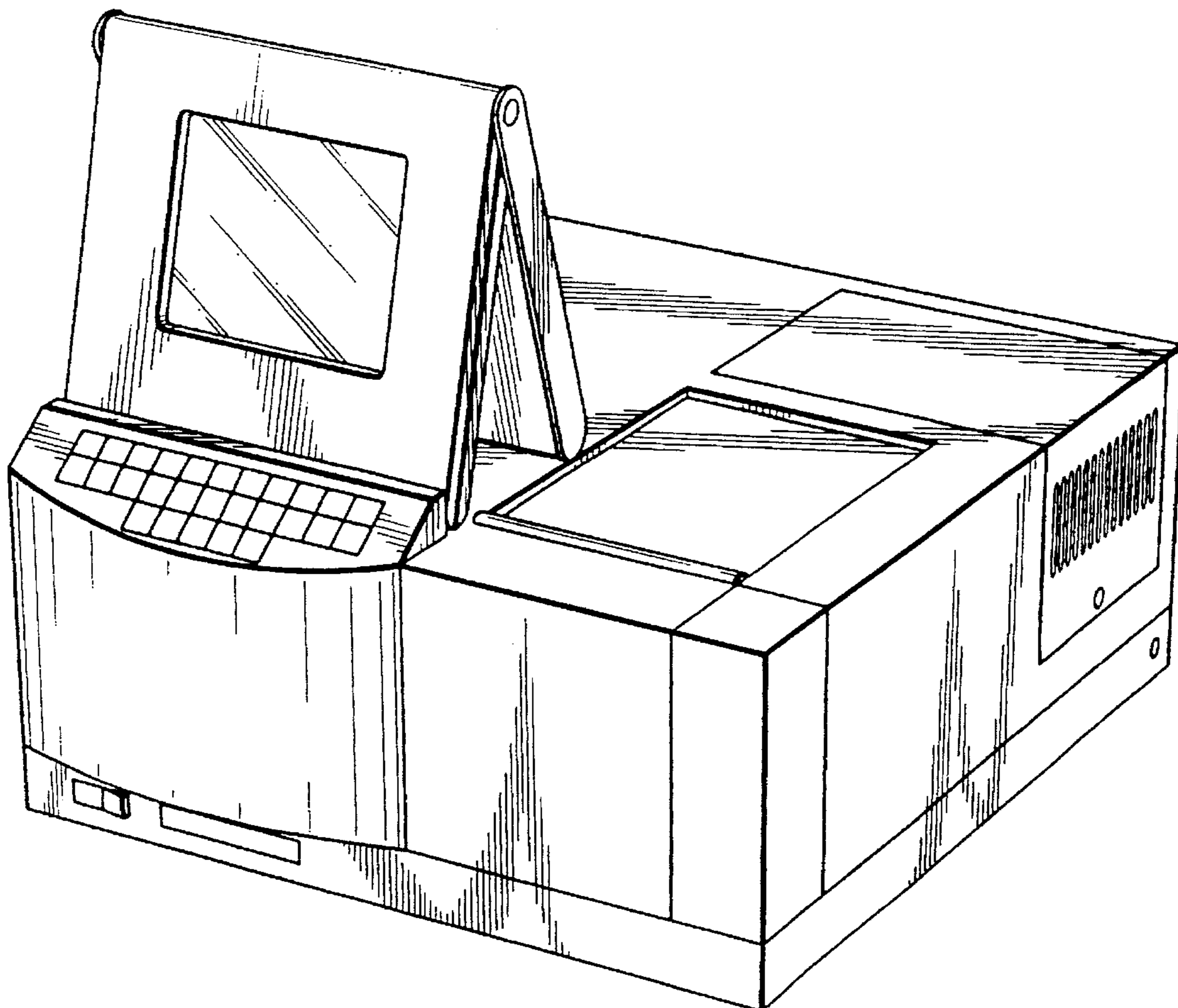


FIG. 1

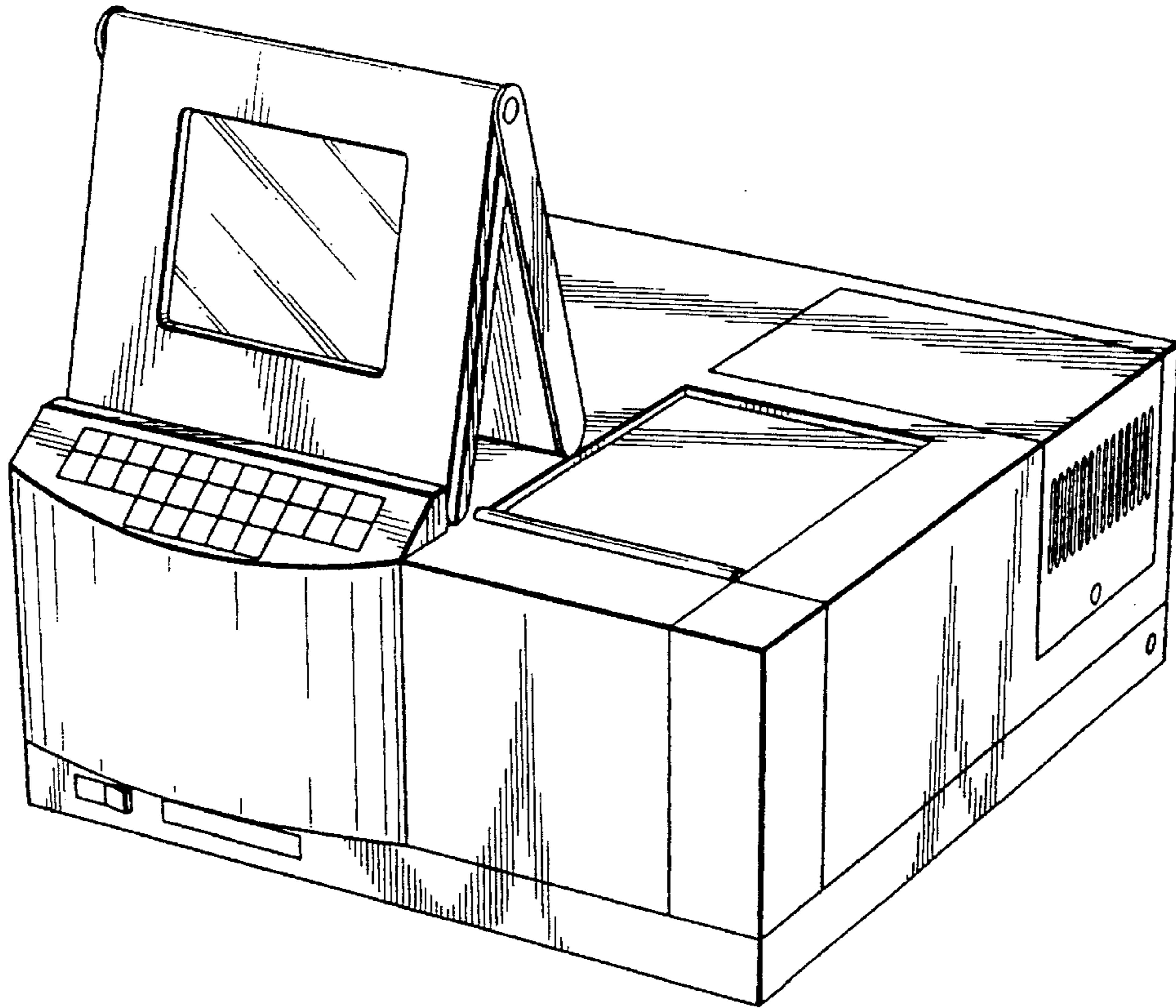


FIG. 2

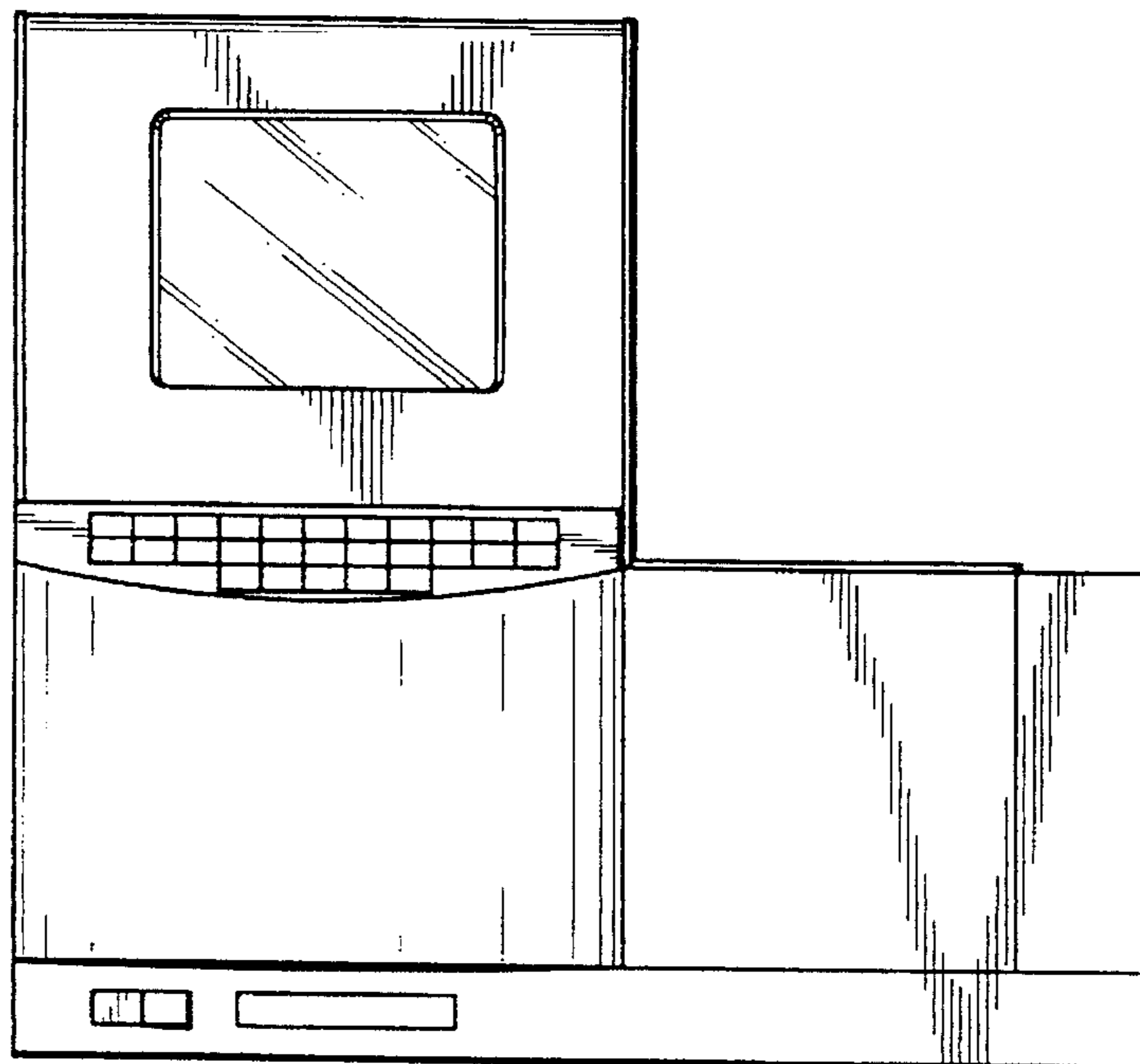


FIG. 3

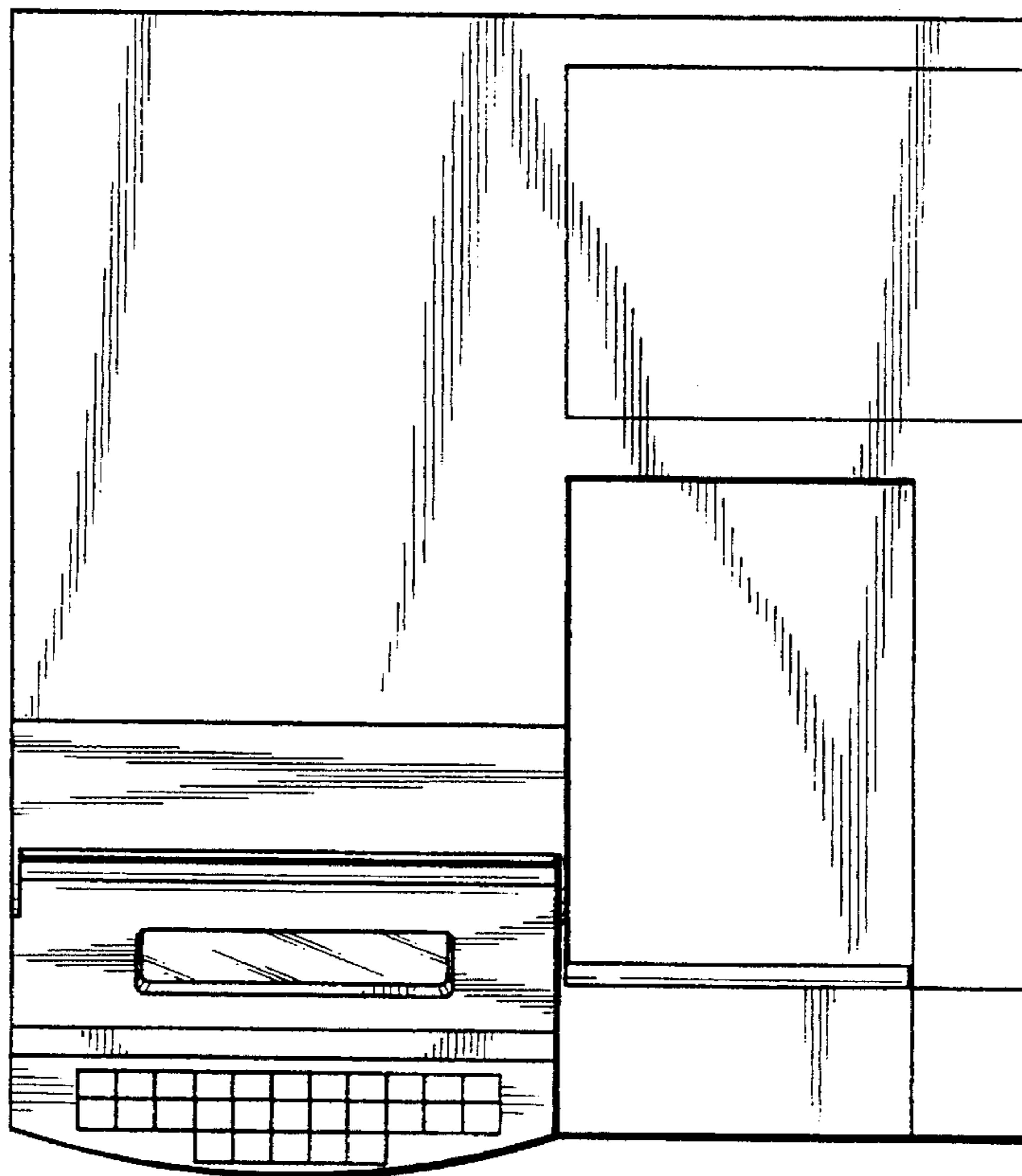


FIG. 4

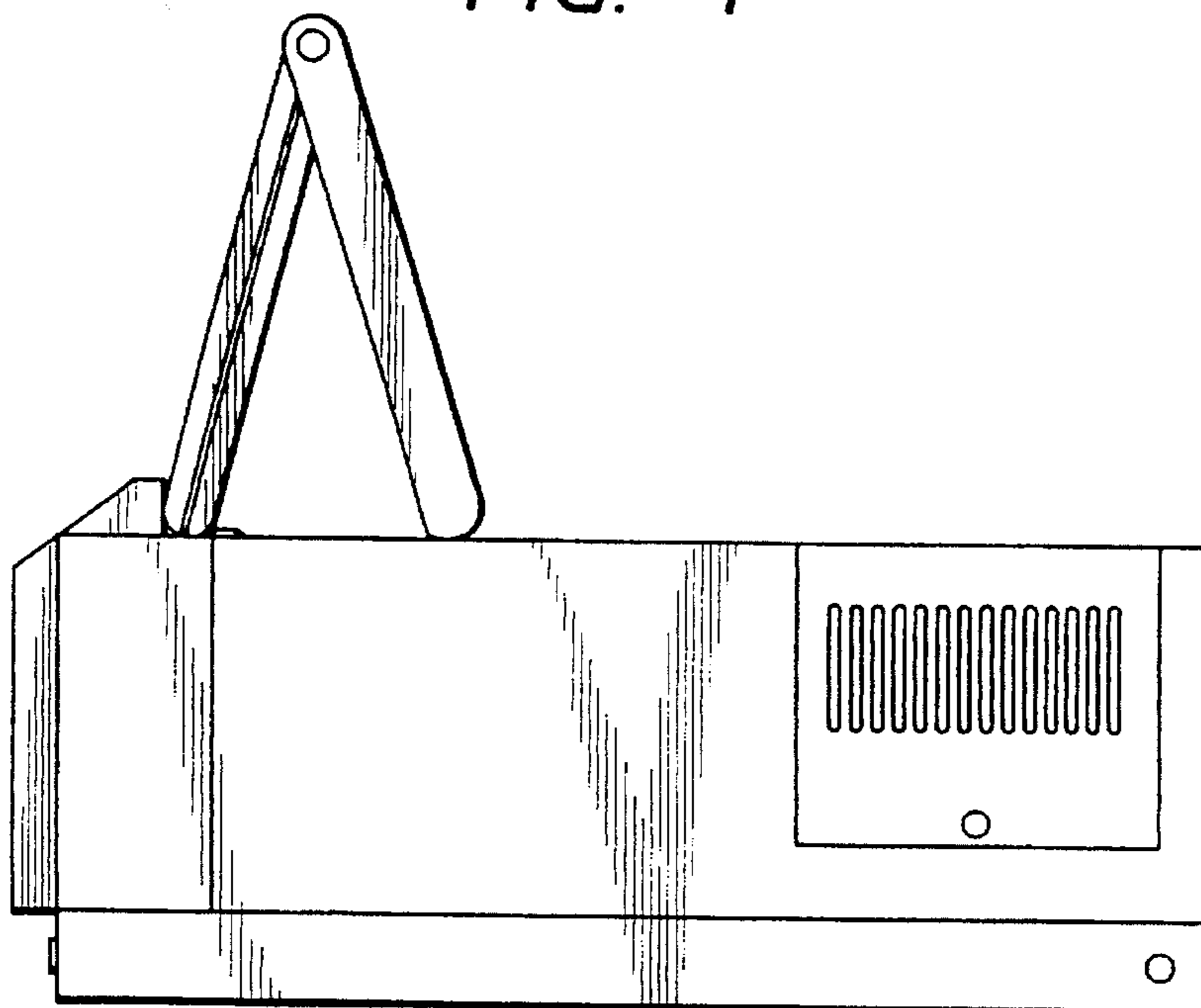


FIG. 5

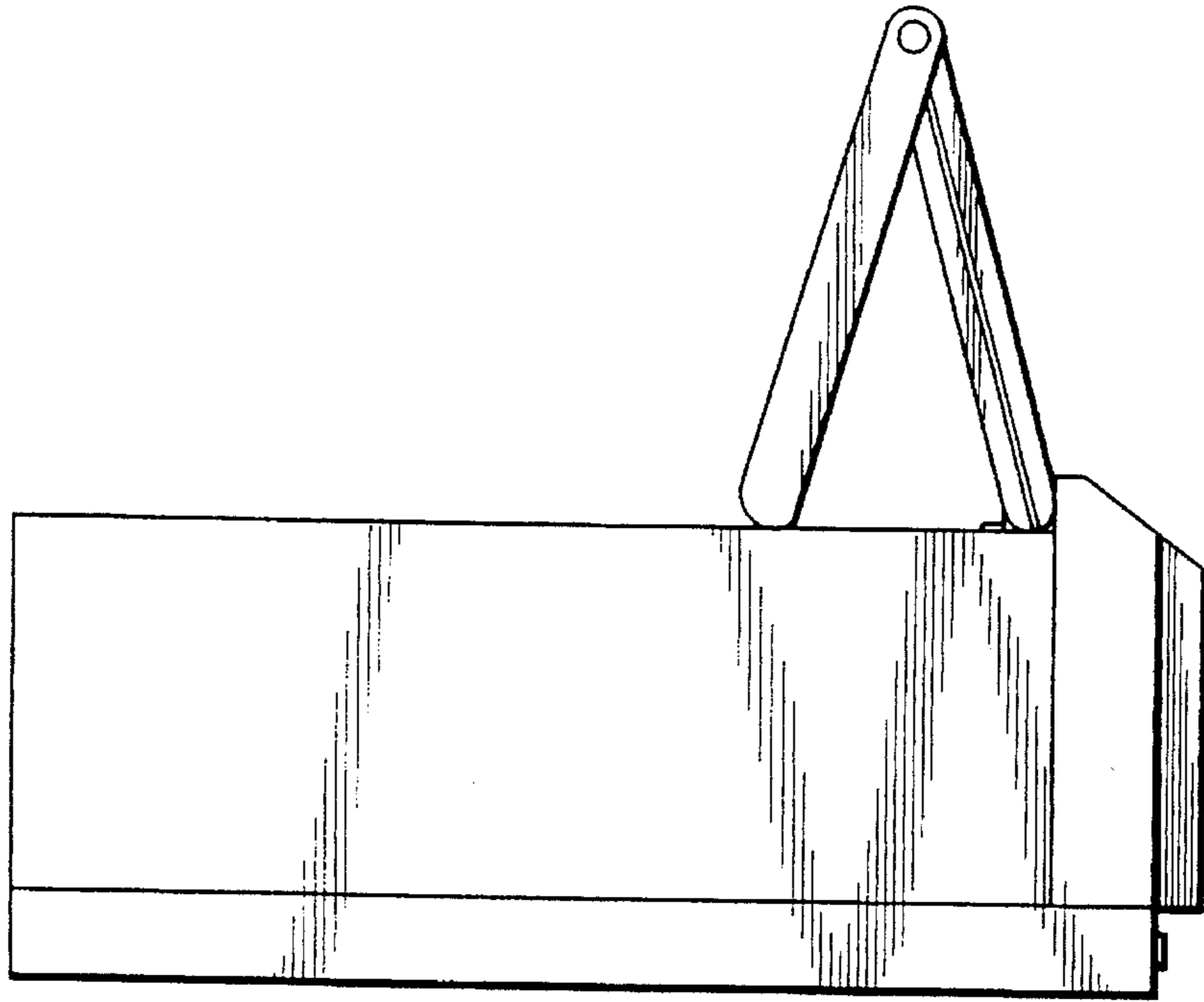


FIG. 6

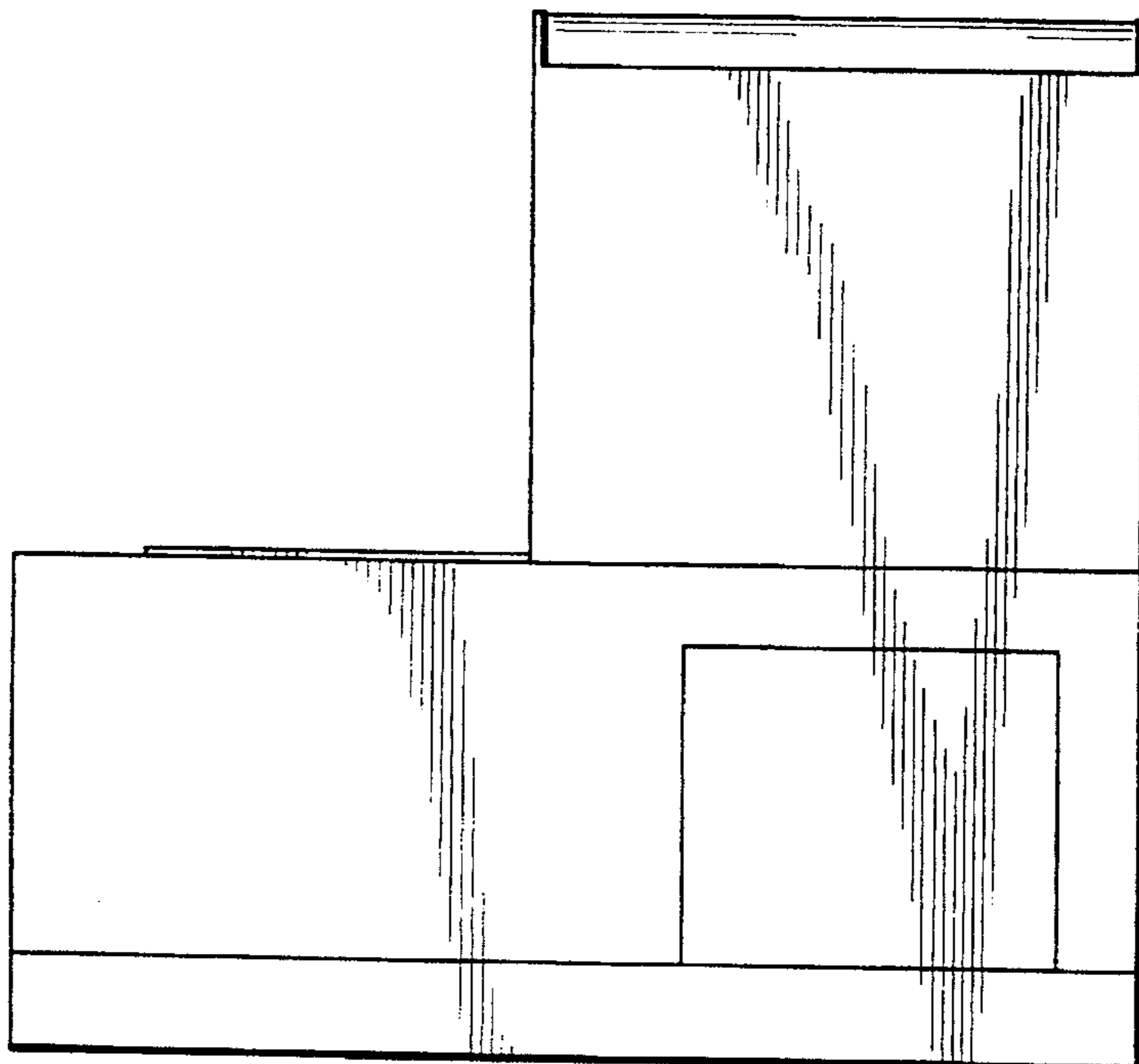


FIG. 7

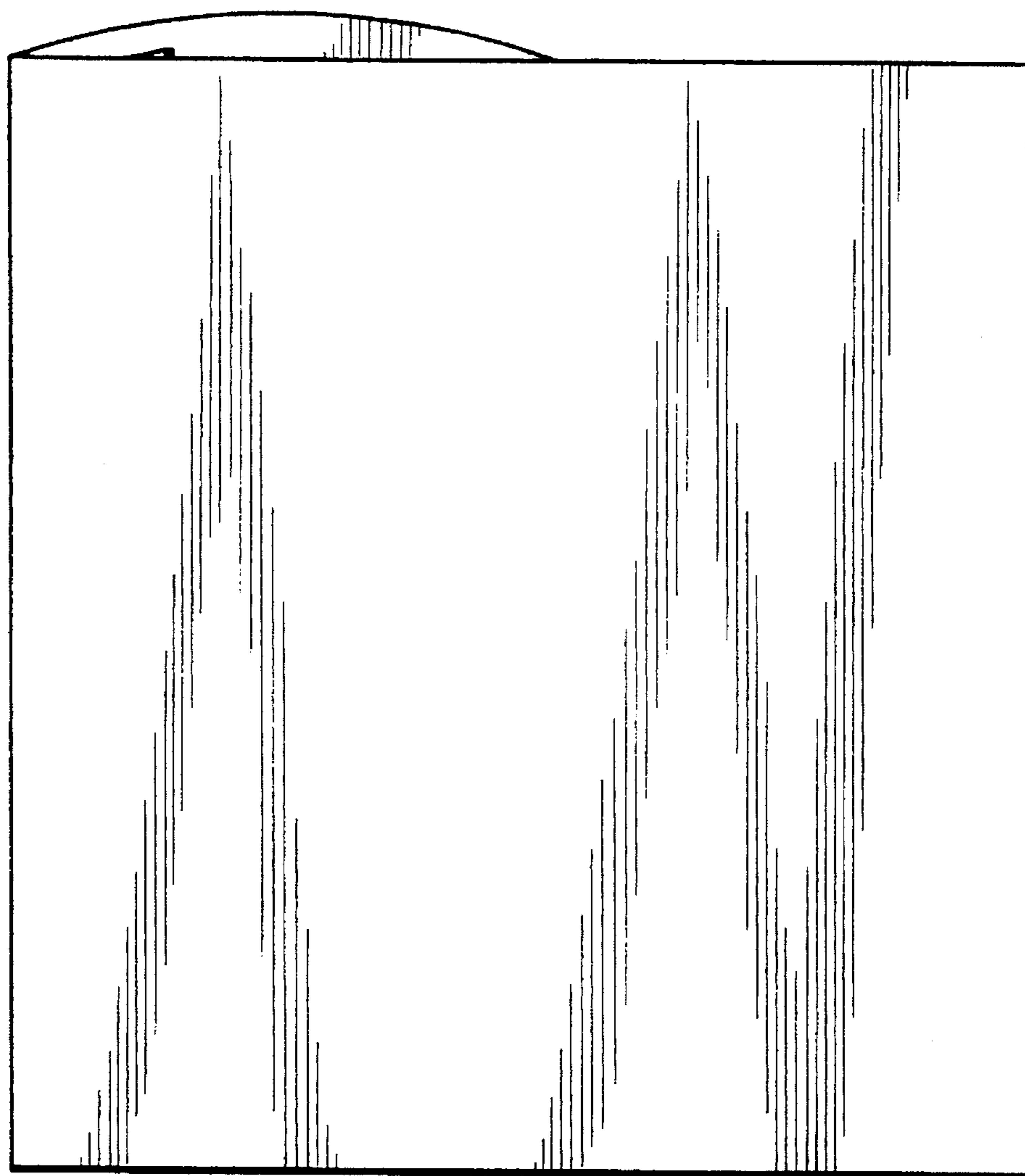


FIG. 8

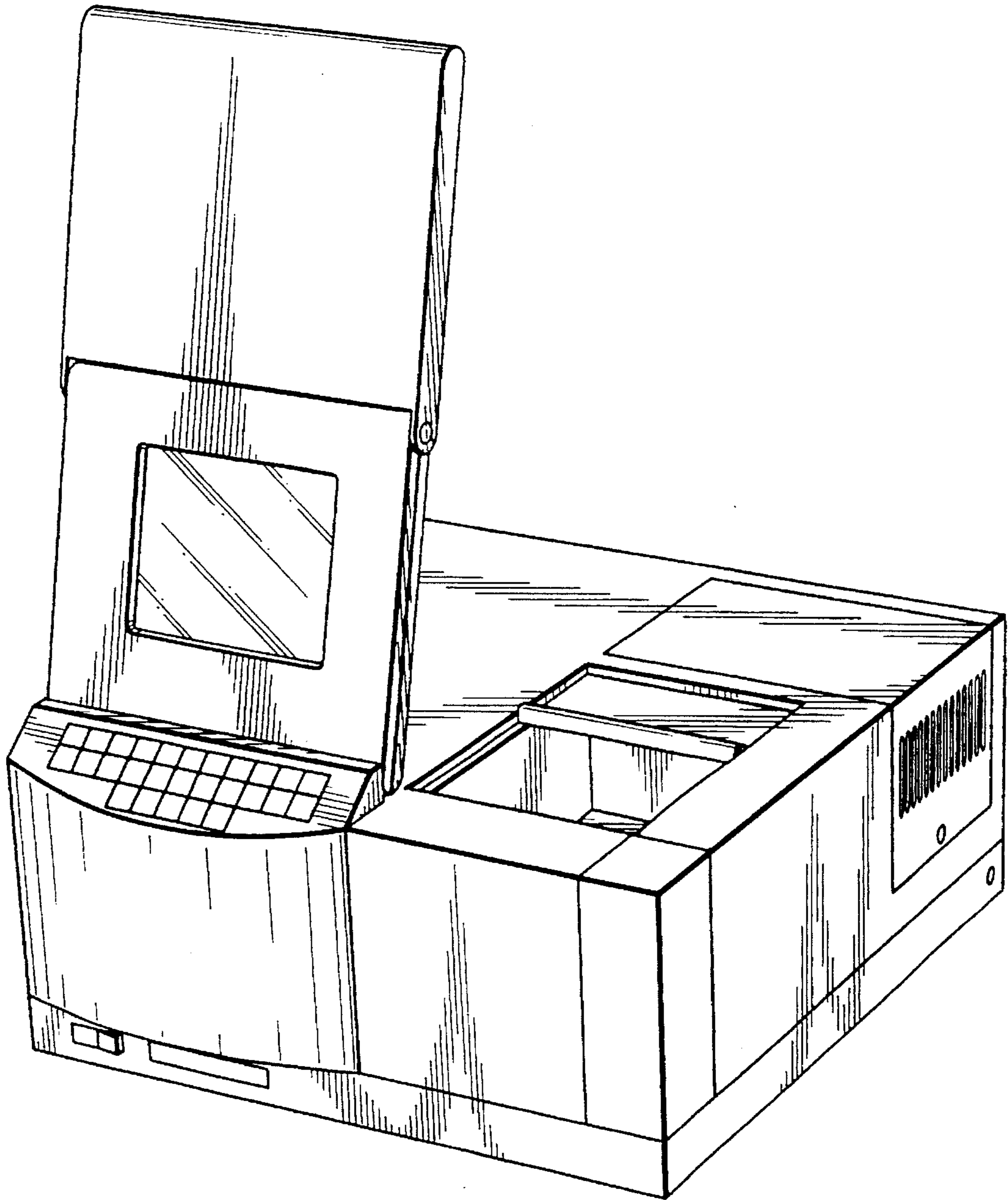
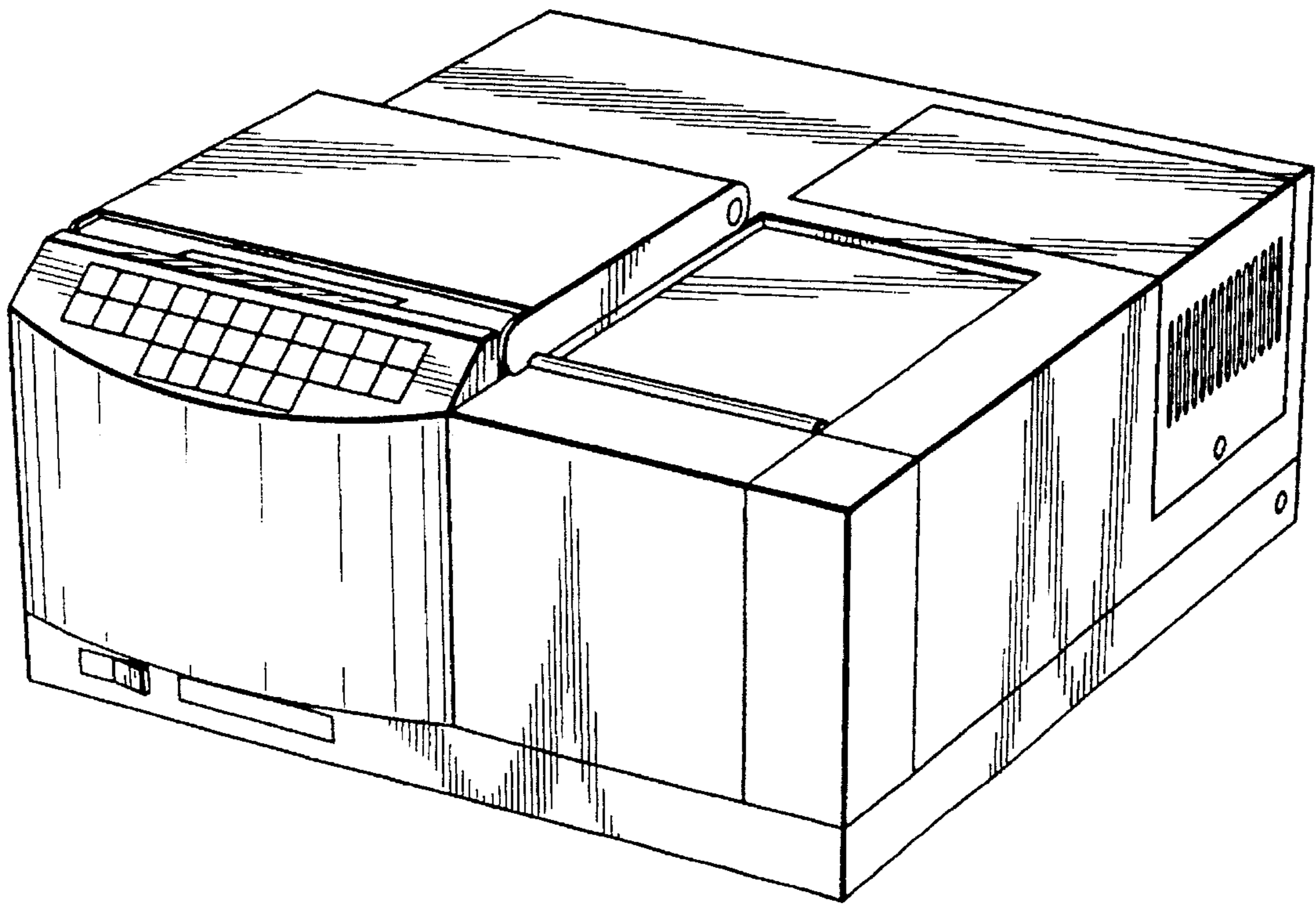


FIG. 9



UNITED STATES PATENT AND TRADEMARK OFFICE
CERTIFICATE OF CORRECTION

PATENT NO. : Des. 373,315
DATED : September 3, 1996
INVENTOR(S) : Ninomiya et al.

It is certified that error appears in the above-identified patent and that said Letters Patent is hereby corrected as shown below: On the title page: Item [30]

insert the following

Priority information --Foreign Application Priority
Data May 31, 1995 Japan.....7-15435--.

Signed and Sealed this
Twelfth Day of November, 1996

Attest:



BRUCE LEHMAN

Attesting Officer

Commissioner of Patents and Trademarks